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Substitute for form 1449A/PTO			<b>C m p l t If Known</b>	
<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (use as many sheets as necessary)			Application Number	TBA
			Filing Date	December 30, 2002
			First Named Inventor	Kwang Nam KIM et al.
			Art Unit	TBA
			Examiner Name	Not Yet Assigned
			Attorney Docket Number	8733.170.21 (US)
Sheet	1	of	2	

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No.	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code* (if known)			
		4,937,095	06-1990	Fukatsu et al.	
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		US-2002/0006689A1	01-2002	Miyasaka	
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FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No.	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	T*
		Country Code* -Number* -Kind Code* (if known)				
		0 678 903 A1	10-25-1995	EPO		
		0 686 708 A1	12-13-1995	EPO		
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		JP 1064696	03-1998	Japan	Abstract	
		JP 58181865	10-1983	Japan	Abstract	
		JP 01107547A	04-1989	Japan		

<sup>1</sup> Applicant's unique citation designation number (optional). <sup>2</sup> See attached Kinds Codes of USPTO Patent Documents at [www.uspto.gov](http://www.uspto.gov) or MPEP 901.04. <sup>3</sup> Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). <sup>4</sup> For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the application number of the patent document. \* Kind of document by the appropriate symbols as indicated on the document under the WIPO Standard ST. 16 if possible. \* Applicant is to place a check mark here if English language Translation is attached.

OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc), date, page(s), volume-issue number(s), publisher, city and/or country where published.			T <sup>2</sup>
		WPI Accession No. 98-236540 & JP 10 074749 A (APPLIED), abstract only			
		WPI Accession No. 90-197031 & JP 2 129377 A (APPLIED), abstract only			
		Stanley Wolf Silicon Processing for the VLSI Era Vol. 2 Lattice Press 1990, pp. 273-274.			

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		Application Number	TBA
		Filing Date	December 30, 2002
		First Named Inventor	Kwang Nam KIM et al.
		Group Art Unit	TBA
		Examiner Name	Not Yet Assigned
		Attorney Docket Number	8733.170.21 (US)
Sheet	2	of	2
		M. Mohamed Salem et al., "Impedance Matching For Optimization of Power Transfer in a Capacitively Excited RF Plasma Reactor", European Physical Journal Applied Physics, EDP Sciences, Les Ulis, Fr, Vol. 3 No. 1, 1998: pages 91-95.	
		Daniel Poitras et al., Characterization of homogeneous and inhomogenous Si-based optical coatings deposited in dual-frequency plasma, September 1996; pp. 2693-2699, Vol. 35, No. 9, Optical Engineering.	
Examiner Signature			Date Considered  

\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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